



Fetterman 7-17

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Patent Application

Applicant(s): H. Scott Fetterman et al.
Case: 7-17
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Signature: Leisa M. Hanin Date: June 25, 2003

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of
Address
S. Hanin*

7-17-03

Title: Stress Migration Test Structure
and Method Therefor

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Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

In accordance with the Manual of Patent Examining Procedure, Section 601.03, please change the mailing address for all correspondence in the above-identified application to:

Joseph B. Ryan
Ryan, Mason & Lewis, LLP
90 Forest Avenue
Locust Valley, New York 11560

Respectfully submitted,

Joseph B. Ryan

Joseph B. Ryan
Reg. No. 37,922
Attorney for Applicant(s)
(516) 759-7517

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